

*Supporting Information for*

**Pinning and Elongating of Electric Treeing Induced by Wrinkled  
Nanosheets in Polymer Dielectrics towards Significantly Enhanced  
High-temperature Energy Storage Performance**

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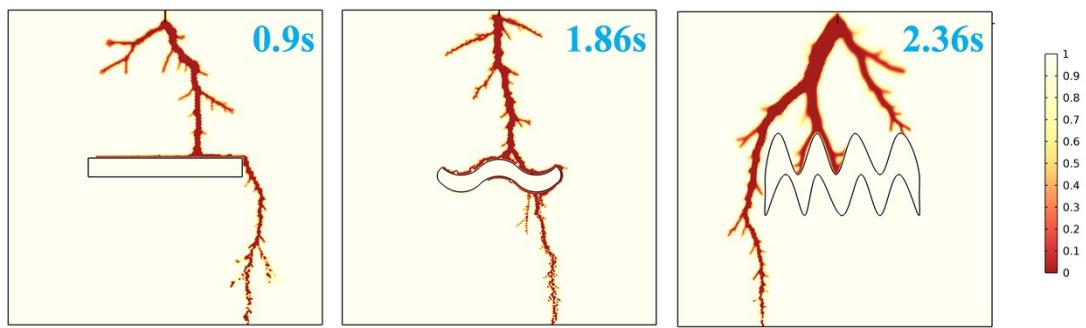
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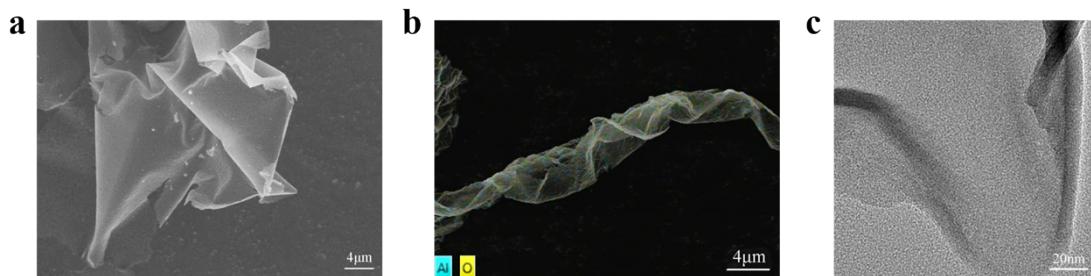
E-mail: zcshi@ouc.edu.cn (Z.Shi)



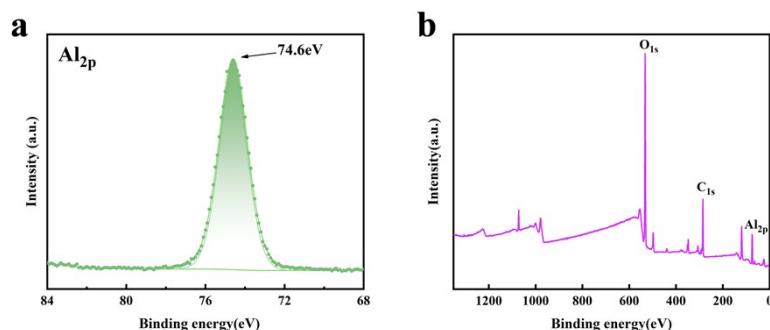
**Figure S1** Simulated breakdown paths of flat (left), low-curvature (middle), and high-curvature (right) nanosheets



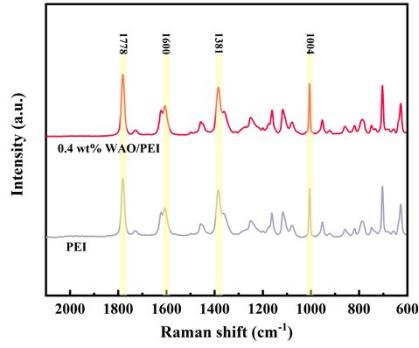
**Figure S2** The Tyndall Effect of WAO Solution (NMP as Solvent)



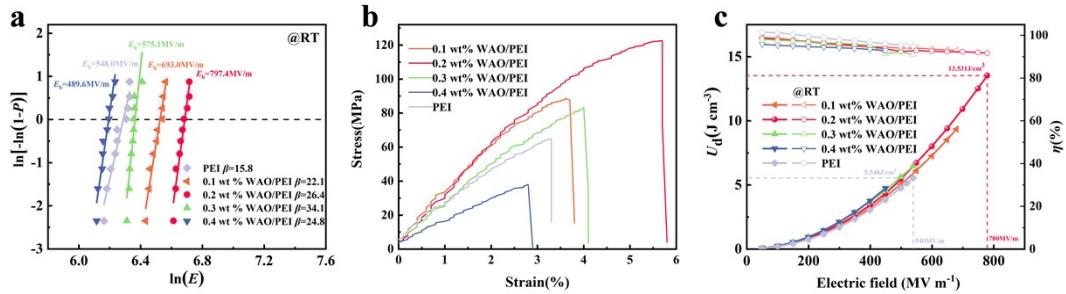
**Figure S3** (a) SEM; (b) EDX and (c) high magnification TEM image of wrinkled nanosheets



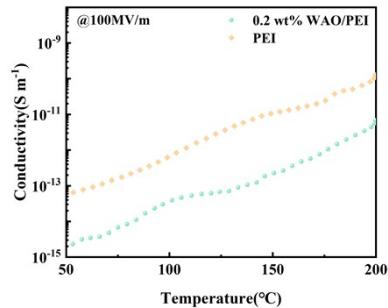
**Figure S4** XPS image of wrinkled  $\text{Al}_2\text{O}_3$  nanosheets



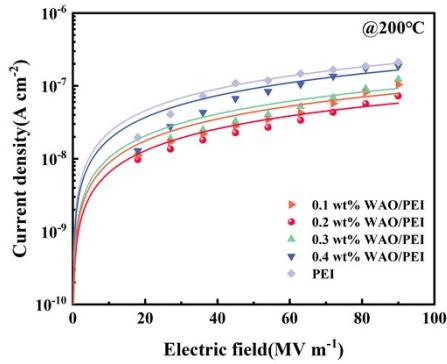
**Figure S5** Raman spectra of pure PEI and 0.4 wt% WAO/PEI films



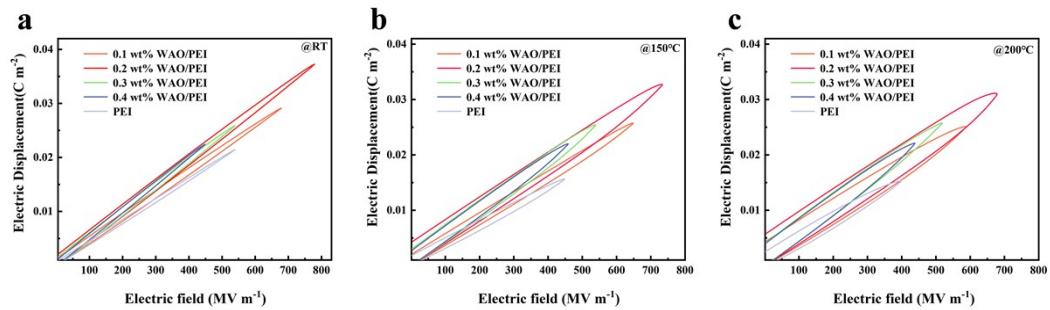
**Figure S6** (a) The breakdown strength; (b) Representative tensile strengths; (c) Energy storage density of pure PEI and 0.1- 0.4 wt% WAO/PEI films at room temperature



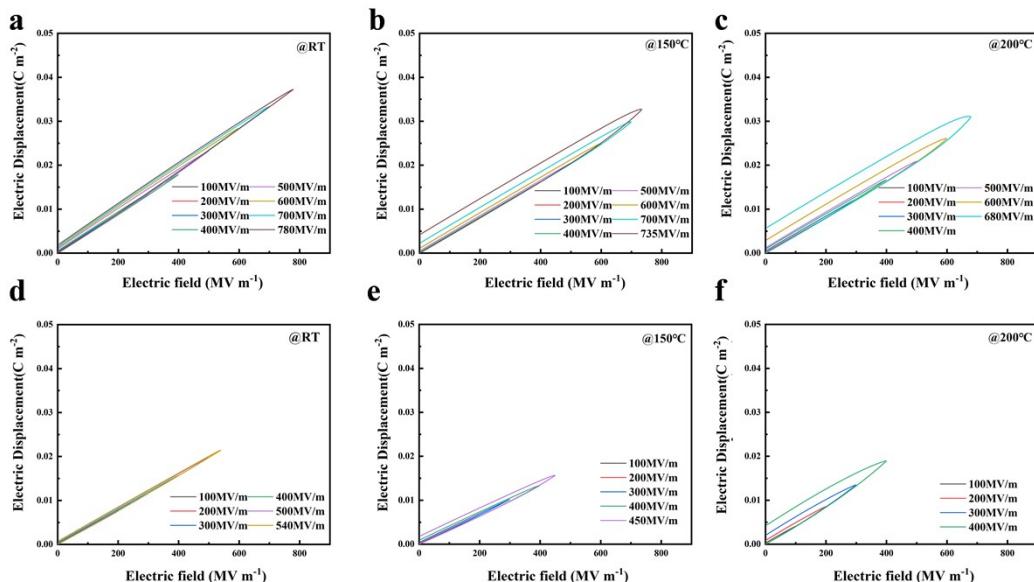
**Figure S7** The temperature-dependent conductivity of pure PEI and 0.2 wt% WAO/PEI composite films



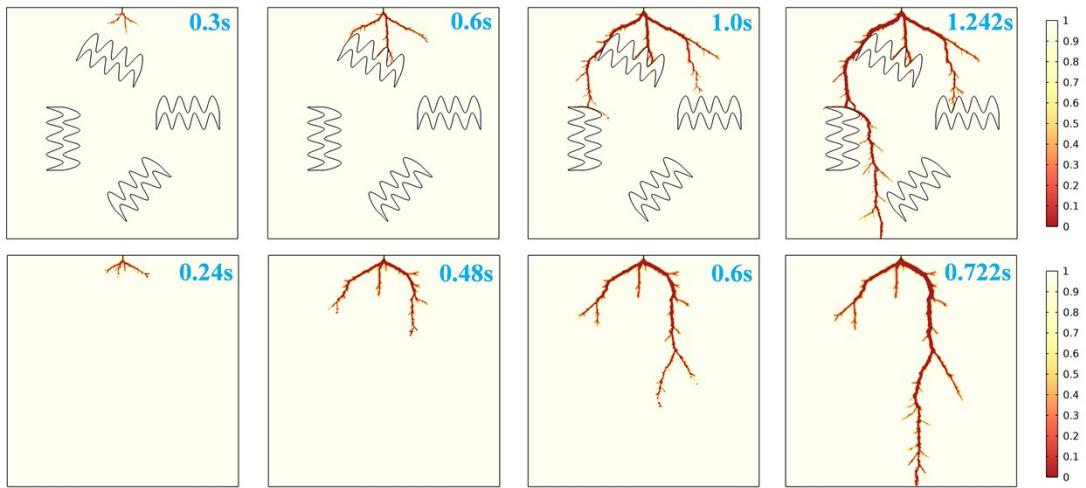
**Figure S8** Leakage current density of pure PEI and 0.1-0.4wt% composite films at 200°C



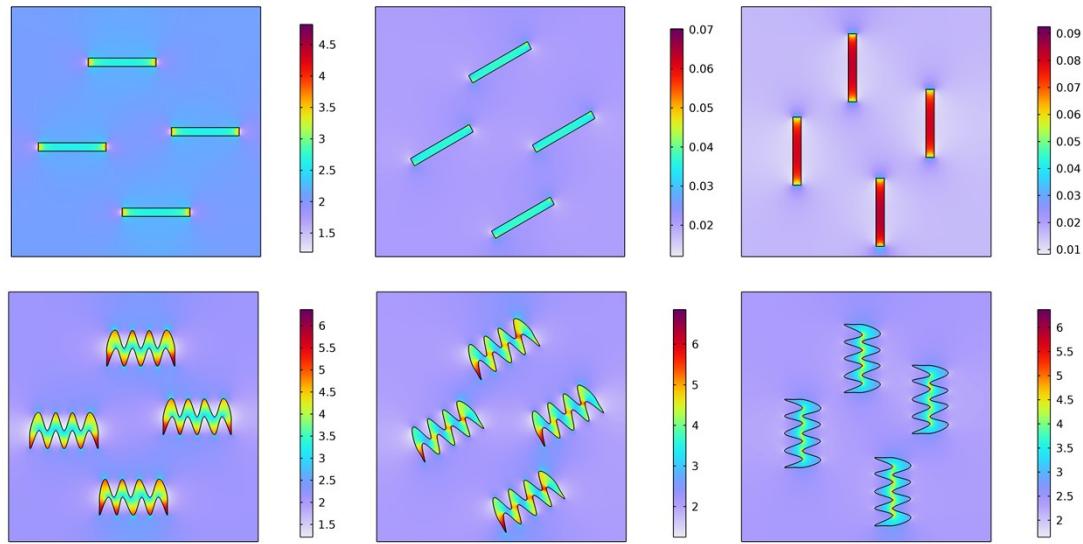
**Figure S9** D-E loops of WAO/PEI at (a) RT, (b) 150 °C, and (c) 200 °C



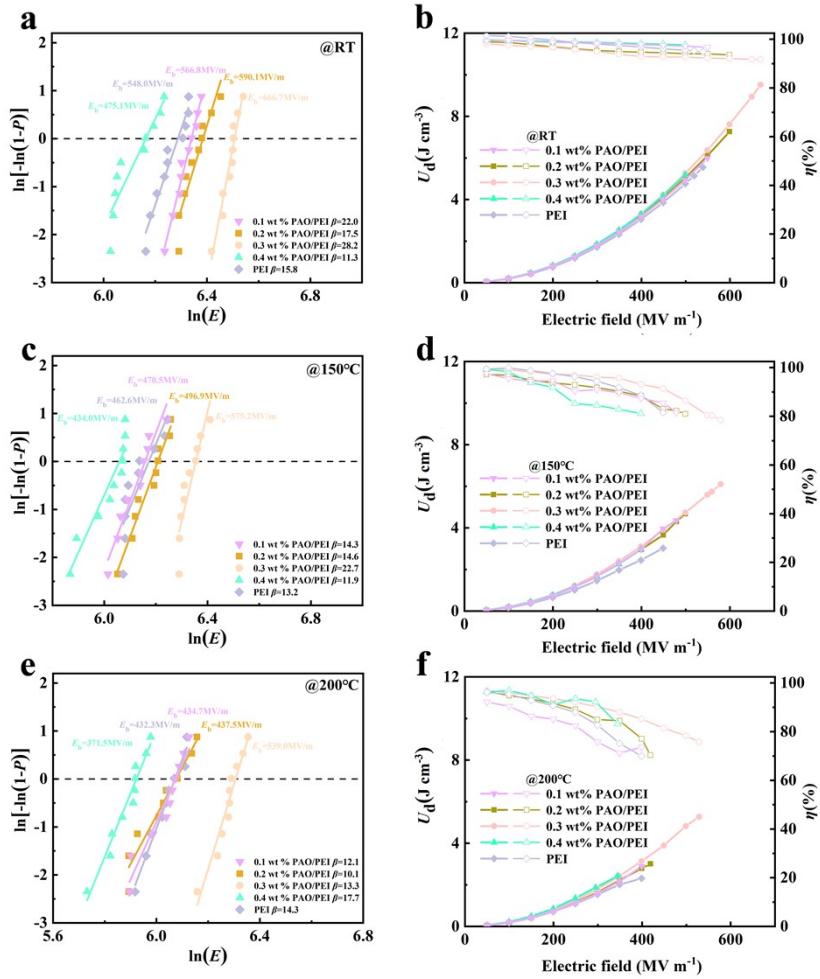
**Figure S10** D-E loops of pure PEI and 0.2 wt% WAO/PEI composite films under different electric fields at room temperature, 150 °C, and 200 °C



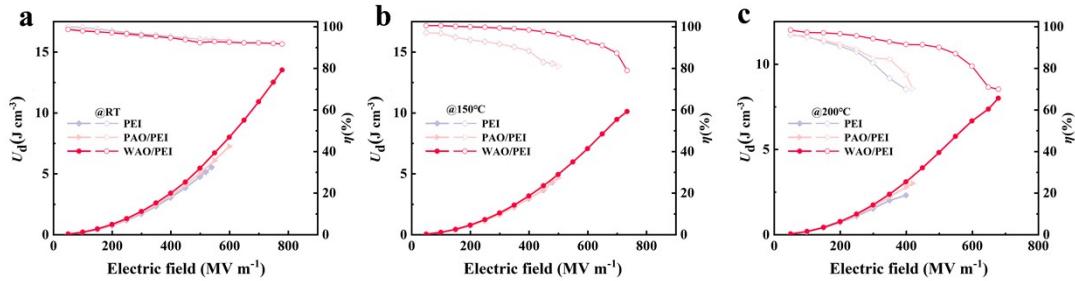
**Figure S11** Breakdown path simulation of WAO/PEI composites (top) and PEI (bottom) via COMSOL software



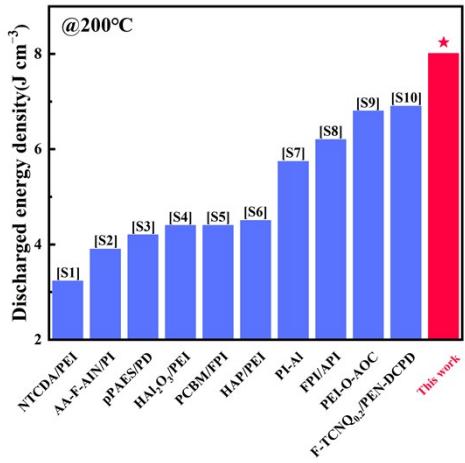
**Figure S12** Polarization of flat nanosheets (top) and wrinkled nanosheets (bottom) with different orientations



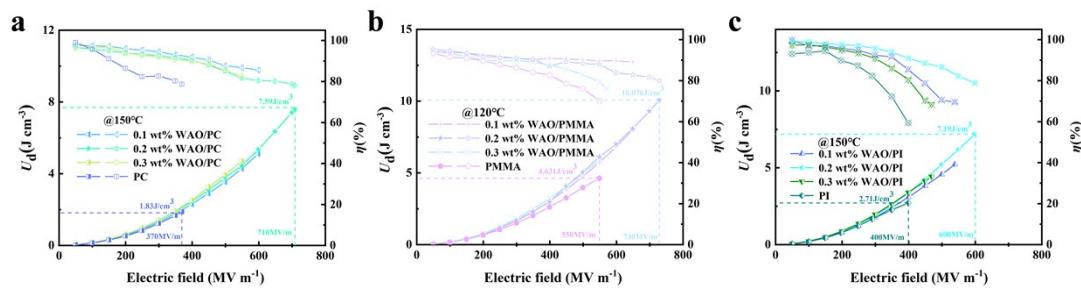
**Figure S13** Breakdown strength and energy storage density of PAO/PEI composites at room temperature, 150 °C, 200 °C



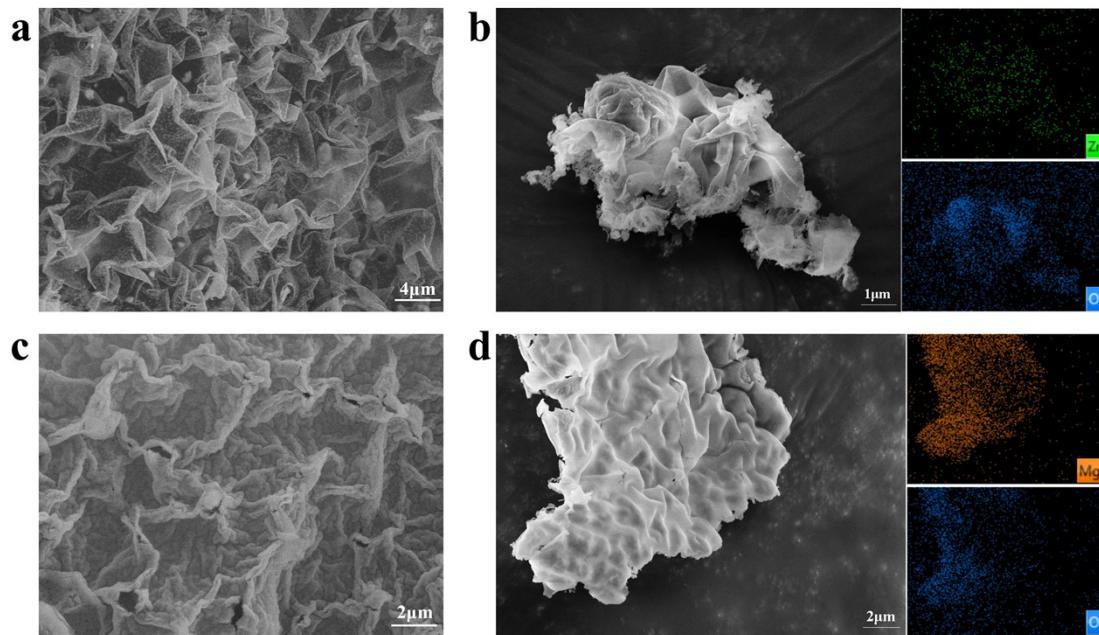
**Figure S14** Energy storage density of pure PEI, 0.2 wt% PAO/PEI and 0.2 wt% WAO/PEI composites at room temperature, 150 °C, 200 °C



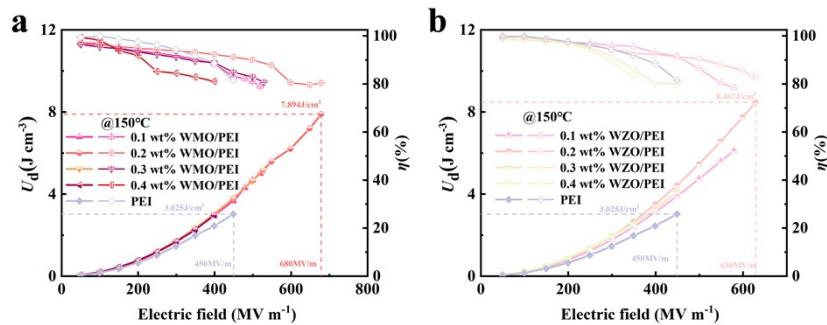
**Figure S15** The maximum discharge energy density at 200°C was compared to the previously published discharge energy density of a high temperature polymer composite film. [S1-S10]



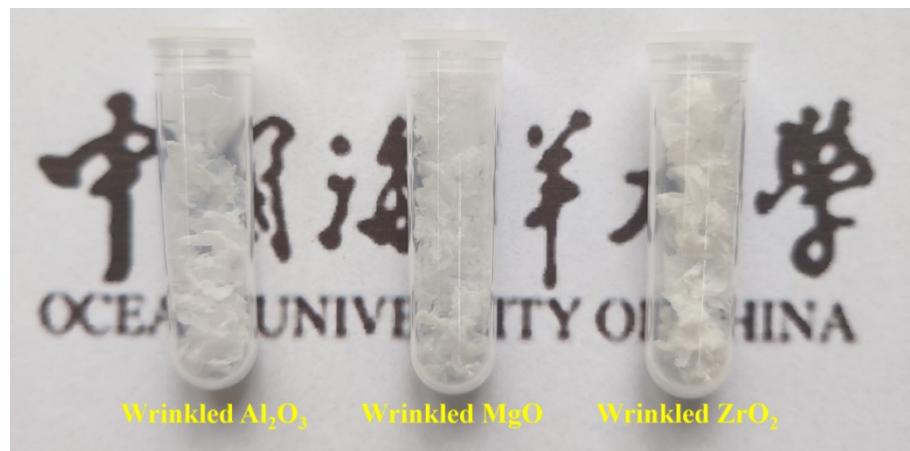
**Figure S16** Energy storage properties of wrinkled alumina incorporated into PC, PMMA, and PI at elevated temperatures



**Figure S17** SEM image of a) wrinkled MgO nanosheets b) wrinkled ZrO<sub>2</sub> nanosheets



**Figure S18** Energy storage properties of wrinkled magnesium oxide and zirconium oxide produced by a similar method incorporating PEI at elevated temperatures



**Figure S19** Macroscopic morphology of wrinkled  $\text{Al}_2\text{O}_3$ ,  $\text{MgO}$  and  $\text{ZrO}_2$

**Table S1** EDX mapping elemental analyses showed the mass fractions of the elements Al and O

Elements	Signal Type	Wt%	Wt% Sigma	At%
O	EDS	50.43	0.69	63.1
Al	EDS	49.57	0.69	36.9

**Table S2** Charge carrier trap depth ( $E$ , eV) and density ( $Q$ , nC) determined by TSDC curves of pure PEI and composite films

Film	Peak 1		Peak 2	
	$E(\text{eV})$	$Q(\text{nC})$	$E(\text{eV})$	$Q(\text{nC})$
WAO/PEI	2.07	64.08	1.29	44.20
PEI	1.45	136.68	0	0

## References

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